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1765

Electronic Filing System (EFS) Data  
Electronic Patent Application Submission  
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EFS ID: 53475  
Application ID: 10675259  
Title of Invention: Method for Controlling Trench  
Depth in Shallow Trench  
Isolation Features  
First Named Inventor: Mario Pita  
Domestic/Foreign Application: Domestic Application  
Filing Date: 2003-09-30  
Effective Receipt Date: 2004-01-12  
Submission Type: Information Disclosure  
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Confirmation number: 4047  
Attorney Docket Number: 075903-240




Total Fees Authorized:

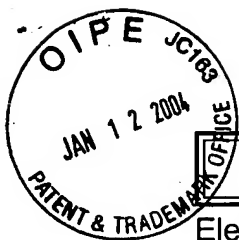
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**TRANSMITTAL**

Electronic Version v1.1

Stylesheet Version v1.1.0


<b>Title of Invention</b>	<b>Method for Controlling Trench Depth in Shallow Trench Isolation Features</b>									
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<table border="1"><thead><tr><th>Submitted by:</th><th>Elec. Sign.</th><th>Sign. Capacity</th></tr></thead><tbody><tr><td>John L. DeAngelis Jr. Registered Number: 30,622</td><td>/John L. DeAngelis, Jr./</td><td>Attorney</td></tr></tbody></table>			Submitted by:	Elec. Sign.	Sign. Capacity	John L. DeAngelis Jr. Registered Number: 30,622	/John L. DeAngelis, Jr./	Attorney		
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<b>Comments</b>										



## ELECTRONIC INFORMATION DISCLOSURE STATEMENT

Electronic Version v18

Stylesheet Version v18.0

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